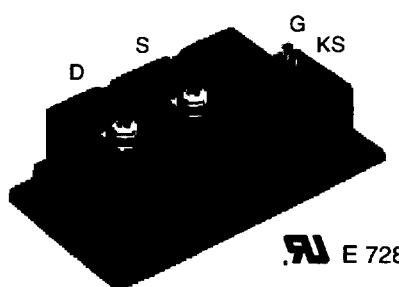
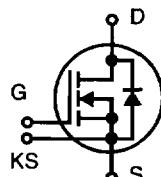


MegaMOS™FET Module

VMO 500-02F

V_{DSS} = 200 V
 I_{D25} = 500 A
 $R_{DS(on)}$ typ = 3.5 mΩ

N-Channel Enhancement Mode

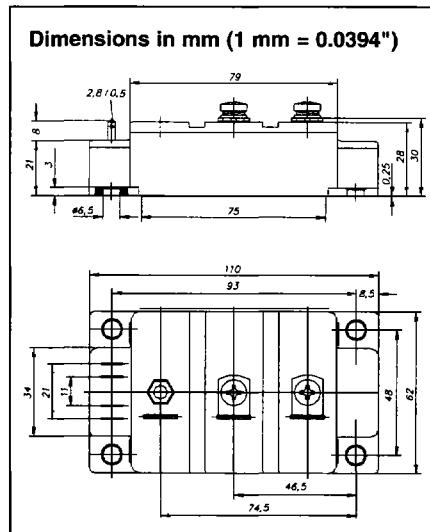


Symbol	Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ\text{C}$ to 150°C	200	V	
V_{DGR}	$T_J = 25^\circ\text{C}$ to 150°C ; $R_{GS} = 10 \text{ k}\Omega$	200	V	
V_{GS}	Continuous	± 20	V	
V_{GSM}	Transient	± 30	V	
I_{D25}	$T_C = 25^\circ\text{C}$ ①	500	A	
I_{D80}	$T_C = 80^\circ\text{C}$	370	A	
I_{DM}	$T_C = 25^\circ\text{C}$, $t_p = 10 \mu\text{s}$ ①	2000	A	
P_D	$T_C = 25^\circ\text{C}$	2200	W	
T_J		-40 ... +150	°C	
T_{Jm}		150	°C	
T_{stg}		-40 ... +125	°C	
V_{ISOL}	50/60 Hz $I_{ISOL} \leq 1 \text{ mA}$	t = 1 min t = 1 s	3000 3600	V~ V~
M_d	Mounting torque (M6) Terminal connection torque (M5)	2.25-2.75/20-25 2.5-3.7/22-33	Nm/lb.in. Nm/lb.in.	
Weight	typical including screws	250	g	

Symbol	Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.	max.
V_{DSS}	$V_{GS} = 0 \text{ V}$, $I_D = 12 \text{ mA}$	200			V
$V_{GS(th)}$	$V_{DS} = 20 \text{ V}$, $I_D = 44 \text{ mA}$	2		4	V
I_{GSS}	$V_{GS} = \pm 20 \text{ V DC}$, $V_{DS} = 0$			± 500	nA
I_{bss}	$V_{DS} = 0.8 \cdot V_{DSS}$, $V_{GS} = 0 \text{ V}$ $T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$			2.4 12	mA
$R_{DS(on)}$	$V_{GS} = 10 \text{ V}$, $I_D = 0.5 \cdot I_{D25}$ Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2 \%$	3.5	4.2		mΩ

① Additional current limitation by external leads

Symbol	Conditions	Characteristic Values			
		($T_J = 25^\circ\text{C}$, unless otherwise specified)	min.	typ.	max.
g_{fs}	$V_{DS} = 10 \text{ V}; I_D = 0.5 \cdot I_{D25}$ pulsed		420	S	
C_{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$		57	nF	
			10	nF	
			3.7	nF	
$t_{d(on)}$	$V_{GS} = 10 \text{ V}, V_{DS} = 0.5 \cdot V_{DSS}, I_D = 0.5 \cdot I_{D25}$		210	ns	
			500	ns	
			900	ns	
			350	ns	
Q_g	$V_{GS} = 10 \text{ V}, V_{DS} = 100 \text{ V}, I_D = 200 \text{ A}$		2500	nC	
			450	nC	
			1200	nC	
R_{thJC}				0.057	K/W
R_{thJK}	with 30 μm heat transfer paste		0.085		K/W



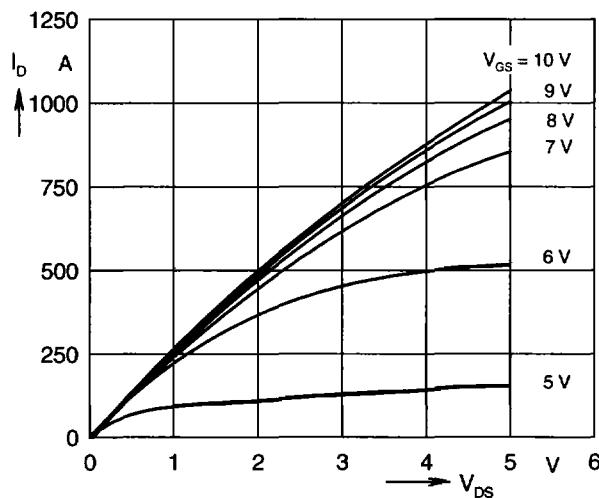
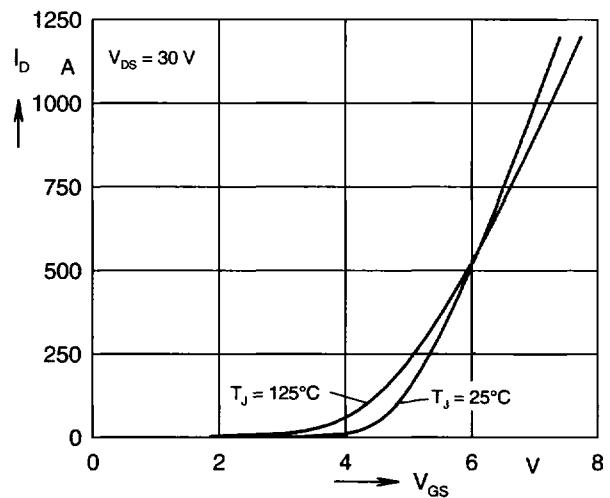
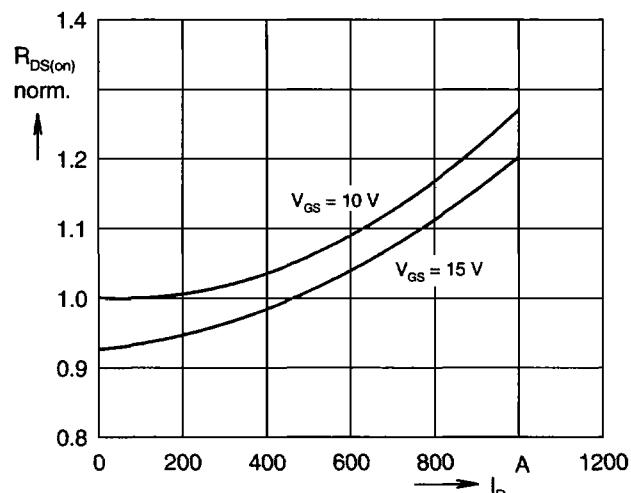
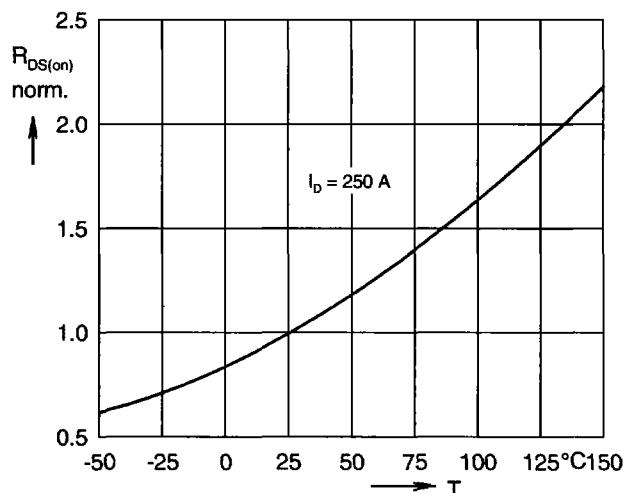
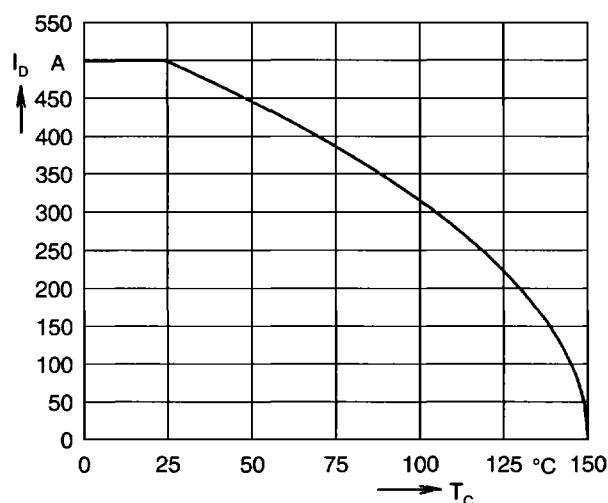
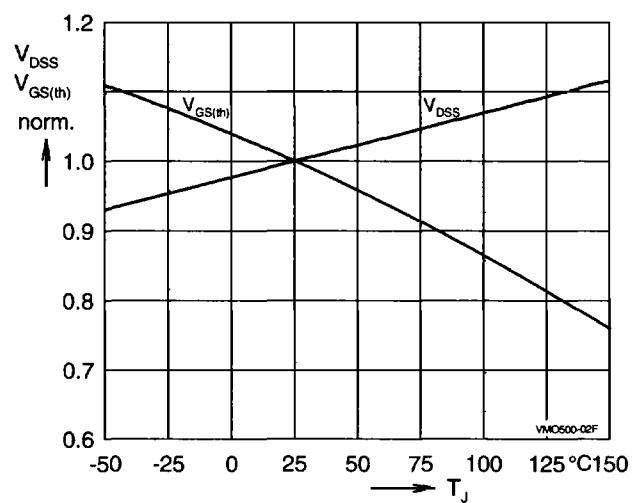
Source-Drain Diode

Characteristic Values

 $(T_J = 25^\circ\text{C}, \text{unless otherwise specified})$

Symbol	Conditions	min.	typ.	max.
I_s	$V_{GS} = 0, T_C = 25^\circ\text{C}, T_J = T_{JM}$ ②		500	A
I_{SM}	Repetitive; pulse width limited by T_{JM} ②		2000	A
V_{SD}	$I_F = 500 \text{ A}; V_{GS} = 0 \text{ V},$ Pulse test, $t \leq 300 \mu\text{s}$, duty cycle $d \leq 2 \%$	1	1.25	V
t_{rr}	$I_F = I_s, -di/dt = 1200 \text{ A}/\mu\text{s}, V_{DS} = 100 \text{ V}$	600		ns

② Additional current limitation by external leads

Fig. 1 Typical output characteristics $I_D = f (V_{DS})$ Fig. 2 Typical transfer characteristics $I_D = f (V_{GS})$ Fig. 3 Typical $R_{DS(\text{on})} = f (I_D)$, normalizedFig. 4 $R_{DS(\text{on})} = f (T_J)$, normalizedFig. 5 Continuous drain current $I_D = f (T_C)$ Fig. 6 $V_{DSS} = f (T_J)$, $V_{GS(\text{th})} = f (T_J)$, normalized

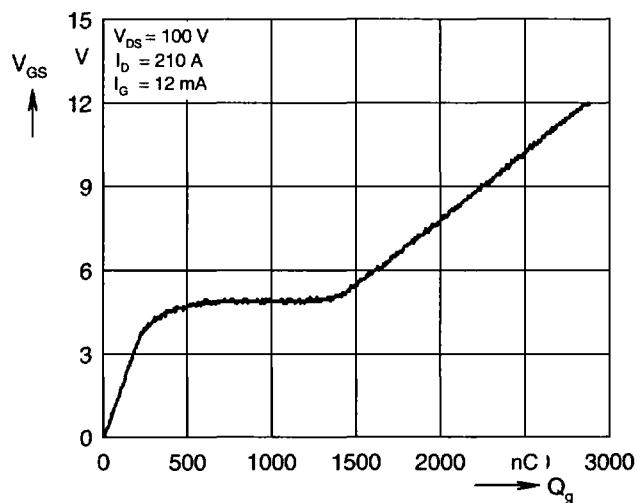


Fig. 7 Typical turn-on gate charge characteristics

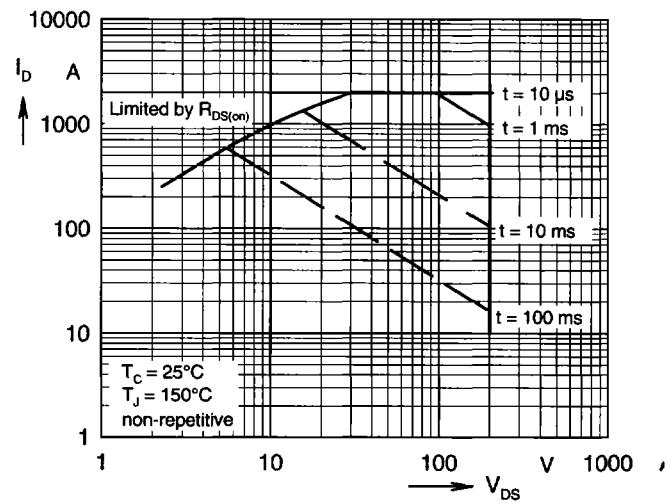


Fig. 8 Forward Bias Safe Operating Area, $I_D = f(V_{DS})$

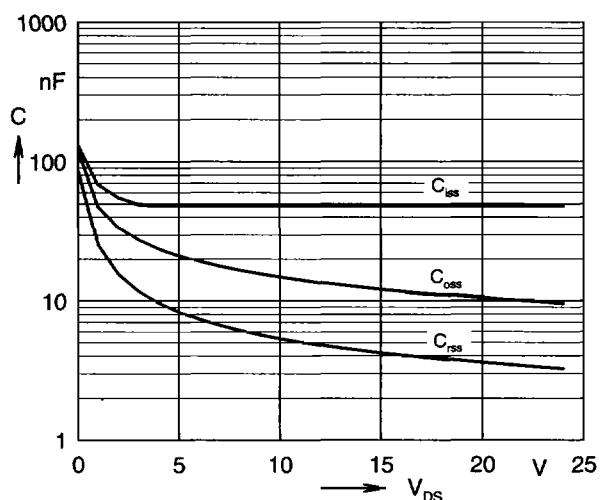


Fig. 9 Typical capacitances $C = f(V_{DS})$, $f = 1$ MHz

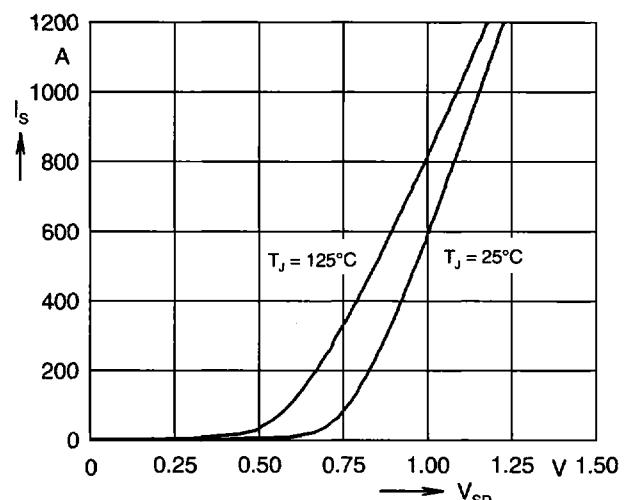


Fig. 10 Typical forward characteristics of reverse diode, $I_s = f(V_{SD})$

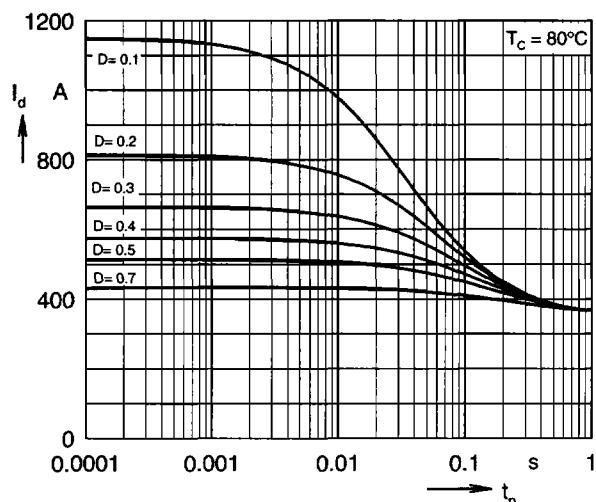


Fig. 11 Drain current versus pulse width and duty cycle

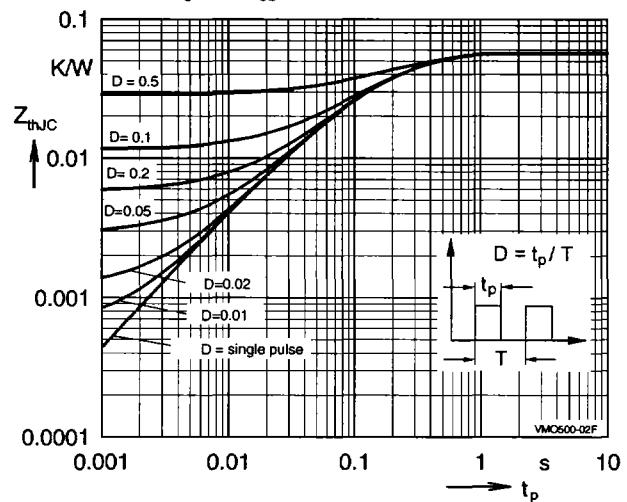


Fig. 12 Transient thermal resistance $Z_{thJC} = f(t_p)$